

N-Channel Enhancement Mode MOSFET

Feature

- 150V/30A
 R_{DS(ON)}=34mΩ (typ.) @ VGs = 10V
- 100% Avalanche Tested
- Reliable and Rugged
- Halogen- Free Devices Available

Pin Description



Applications

- Power Switching application
- LED drive power
- Power Management for DC/DC



N-Channel MOSFET

Ordering and Marking Information



Package Code

P:TO-252-2L

Date Code

XYMXXXXXX

Note: HUAYI lead-free products contain molding compounds/die attach materials and 100% matte tin plateTermi-Nation finish; which are fully compliant with RoHS. HUAYI lead-free products meet or exceed the lead-Free requirements of IPC/JEDEC J-STD-020 for MSL classification at lead-free peak reflow temperature. HUAYI defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

HUAYI reserves the right to make changes, corrections, enhancements, modifications, and improvements to this pr-oduct and/or to this document at any time without notice.



Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit	
Common Rat	tings (Tc=25°C Unless Otherwise Noted)		,	
VDSS	Drain-Source Voltage		150	V
Vgss	Gate-Source Voltage		±20	V
TJ	Maximum Junction Temperature		-55 to 175	°C
Тѕтс	Storage Temperature Range		-55 to 175	°C
ls	Source Current-Continuous(Body Diode) Tc=25°C		30	А
Mounted on	Large Heat Sink		,	
lом	Pulsed Drain Current *	Tc=25°C	100	А
	Continuous Danie Comment	Tc=25°C	30	А
lo	Continuous Drain Current	Tc=100°C	21	А
	M	Tc=25°C	63	W
P _D Maximum Power Dissipation		Tc=100°C	32	W
R _θ JC	Thermal Resistance, Junction-to-Case		2.35	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient **		60	°C/W
Eas	Single Pulsed-Avalanche Energy ***	L=0.3mH	75	mJ

Note: * Repetitive rating; pulse width limited by max. junction temperature.

** Surface mounted on FR-4 board.

*** Limited by TJmax, starting TJ=25°C, L = 0.3mH, VDS=100V, VGS =10V.

Electrical Characteristics (Tc = 25°C Unless Otherwise Noted)

Cumbal	Parameter	Test Conditions	HYG400N15NS1		11	
Symbol	Symbol Parameter Test Conditions		Min	Тур.	Max	Unit
Static Cha	Static Characteristics					
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V,I _{DS} =250μA	150	-	-	V
I Design to Course Lealure Courset		V _{DS} =150V,V _{GS} =0V	-	-	1.0	μA
I _{DSS} Drain-to-Sour	Drain-to-Source Leakage Current	T _J =125°C	-	-	50	μA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250µA	2	3	4	V
Igss	Gate-Source Leakage Current	V _{GS} =±20V,V _{DS} =0V	-	-	±100	nA
RDS(ON)*	Drain-Source On-State Resistance	V _{GS} =10V,I _{DS} =20A	-	34	41	mΩ
Diode Cha	Diode Characteristics					
VsD*	Diode Forward Voltage	IsD=20A,VGS=0V	-	0.87	1.3	٧
trr	Reverse Recovery Time	- Isp=20A,dIsp/dt=100A/µs	<u>-</u>	64.2	_	ns
Qrr	Reverse Recovery Charge	15D-20A, UISD/UI- TOUA/µS	-	205.1	-	nC

HYG400N15NS1D



Electrical Characteristics (Cont.) (Tc =25°C Unless Otherwise Noted)

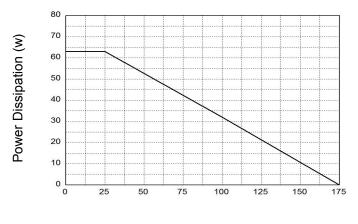
Symbol	Davie wester	Test Conditions	HYG400N15NS1		NS1	1114
	Parameter		Min	Тур.	Max	Unit
Dynamic	Characteristics					
Rg	Gate Resistance	V _{GS} =0V,V _{DS} =0V,F=1MHz	-	2.1	-	Ω
Ciss	Input Capacitance	V _{GS} =0V,	-	2140	-	
Coss	Output Capacitance	Vps=75V,	-	101	-] pF
Crss	Reverse Transfer Capacitance	Frequency=1.0MHz	-	2.5	-	F.,
td(ON)	Turn-on Delay Time		-	13.7	-	
Tr	Turn-on Rise Time	V_{DD} =75 V , R_{G} =4 Ω ,	-	29.1	-	
td(OFF)	Turn-off Delay Time	IDS=20A,VGS=10V	-	25	-	ns
Tf	Turn-off Fall Time		-	18.2	-	
Gate Cha	rge Characteristics	·				
Qg	Total Gate Charge	\/ -75\/ \/ -10\/	-	30	-	
Qgs	Gate-Source Charge	V_{DS} =75V, V_{GS} =10V,	-	13	-	nC
Qgd	Gate-Drain Charge	I _D =20A	-	4	-	

Note: *Pulse test, pulse width ≤ 300 us, duty cycle $\leq 2\%$



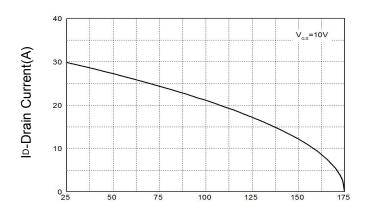
Typical Operating Characteristics

Figure 1: Power Dissipation



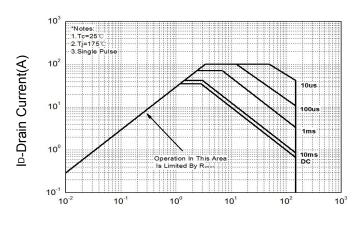
Tc-Case Temperature(°C)

Figure 2: Drain Current



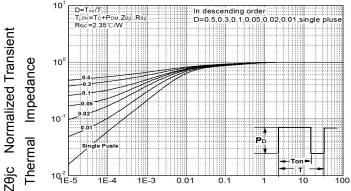
Tc-Case Temperature(°C)

Figure 3: Safe Operation Area



V_{DS}-Drain-Source Voltage(V)

Figure 4: Thermal Transient Impedance



Maximum Effective Transient Thermal Impedance, Junction-to-Case

Figure 5: Output Characteristics

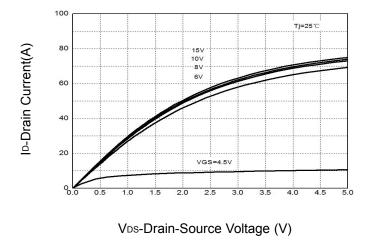
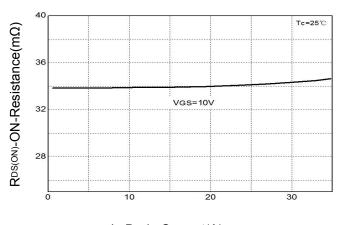


Figure 6: Drain-Source On Resistance



ID-Drain Current(A)



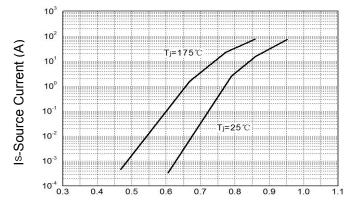
Typical Operating Characteristics(Cont.)

Figure 7: On-Resistance vs. Temperature

2.5
2.0
Vos=10V,lbs=20A
1.5
0.5

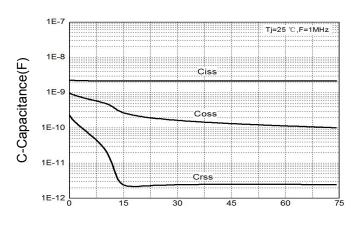
Tj-Junction Temperature (°C)

Figure 8: Source-Drain Diode Forward



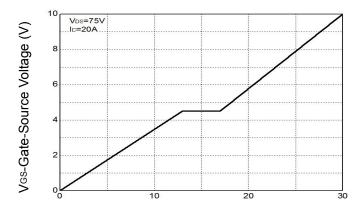
Vsp-Source-Drain Voltage(V)

Figure 9: Capacitance Characteristics



V_{DS}-Drain-Source Voltage (V)

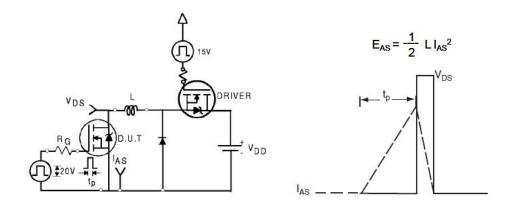
Figure 10: Gate Charge Characteristics



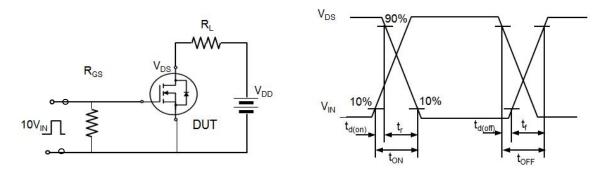
QG-Gate Charge (nC)



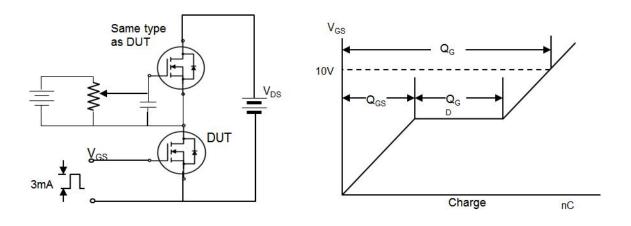
Avalanche Test Circuit



Switching Time Test Circuit



Gate Charge Test Circuit



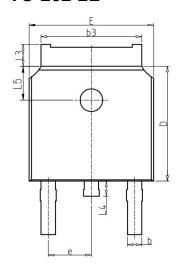


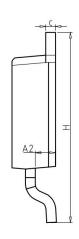
Device Per Unit

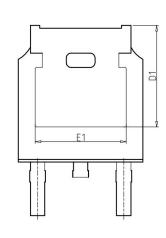
Package Type	Unit	Quantity
TO-252-2L	Tube	75
TO-252-2L	Reel	2500

Package Information

TO-252-2L





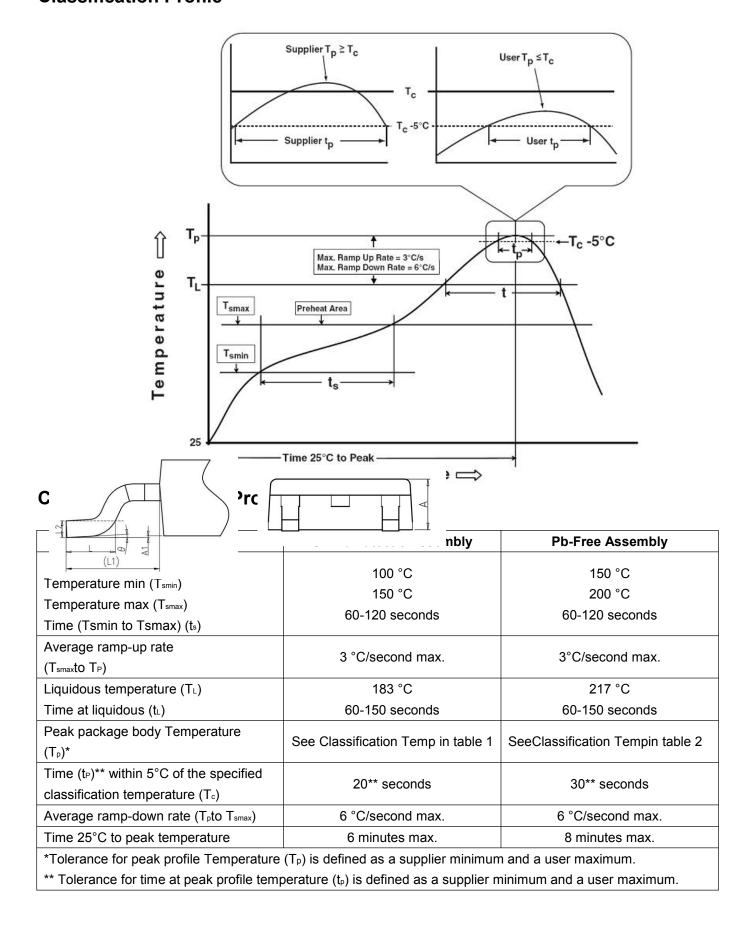


COMMON DIMENSIONS

	mm			
SYMBOL	MIN	NOM	MAX	
Α	2.20	2.30	2.40	
A1	0.00	-	0.20	
A2	0.97	1.07	1.17	
b	0.68	0.78	0.90	
b3	5.20	5.33	5.50	
С	0.43	0.53	0.63	
D	5.98	6.10	6.22	
D1		5.30REF		
Е	6.40	6.60	6.80	
E1	4.63	-	-	
е		2.286BS0		
Н	9.40	10.10	10.50	
L	1.38	1.50	1.75	
L1	2.90REF			
L2	0.51BSC			
L3	0.88 -		1.28	
L4	-	-	1.00	
L5	1.65	1.80	1.95	
θ	0°	-	8°	



Classification Profile



HYG400N15NS1D



Table 1.SnPb Eutectic Process – Classification Temperatures (Tc)

Package	Volume mm³	Volume mm³
Thickness	<350	≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2.Pb-free Process – Classification Temperatures (Tc)

Package	Volume mm³	Volume mm³	Volume mm³
Thickness	<350	350-2000	≥2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HTRB	JESD-22, A108	168/500/1000 Hrs, Bias @ 150°C
HTGB	JESD-22, A108	168 Hrs/500hr/1000hr, Vgs100% @ 150°C
PCT	JESD-22, A102	96 Hrs, 100%RH, 2atm, 121°C
TCT	JESD-22, A104	500 Cycles, -55°C~150°C

Customer Service

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